

SKM 200 GARL 066 T



SEMITRANS® 5

Trench IGBT Modules

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Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Integrated NTC temperature sensor

Typical Applications*

- UPS
- INVERTER

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max, recommended $T_{op} = -40..+150^\circ\text{C}$
- Recommended $T_{op} = -40..+150^\circ\text{C}$
- T_{vj} is intended as absolute maximum rating
- Fig.2 is referred to IGBT current capability



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Absolute Maximum Ratings		$T_{case} = 25^\circ\text{C}$, unless otherwise specified		
Symbol	Conditions	Values	Units	
IGBT				
V_{CES}	$T_j = 25^\circ\text{C}$	600	V	
I_C	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	280	A
		$T_c = 80^\circ\text{C}$	210	A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	400	A	
V_{GES}		± 20	V	
t_{psc}	$V_{CC} = 360\text{ V}; V_{GE} \leq 15\text{ V}; T_j = 150^\circ\text{C}$ $V_{CES} < 600\text{ V}$	6	μs	
Inverse Diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	27	A
		$T_c = 80^\circ\text{C}$	20	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	40	A	
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150^\circ\text{C}$	95	A	
Freewheeling Diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	270	A
		$T_c = 80^\circ\text{C}$	200	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	400	A	
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150^\circ\text{C}$	1620	A	
Module				
$I_{t(RMS)}$		500	A	
T_{vj}		-40 ... +175	$^\circ\text{C}$	
T_{stg}		-40 ... +125	$^\circ\text{C}$	
V_{isol}	AC, 1 min.	2500	V	

Characteristics		$T_{case} = 25^\circ\text{C}$, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 3,2\text{ mA}$	5	5,8	6,5	V
I_{CES}	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES} \quad T_j = 25^\circ\text{C}$			0,5	mA
I_{GES}	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V} \quad T_j = 25^\circ\text{C}$			1200	nA
V_{CE0}		$T_j = 25^\circ\text{C}$	0,9	1	V
		$T_j = 150^\circ\text{C}$	0,7	0,8	V
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$	2,7	4,5	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	5	6,5	$\text{m}\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 200\text{ A}, V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$	1,45	1,9	V
		$T_j = 150^\circ\text{C}_{chiplev.}$	1,7	2,1	V
C_{ies}	$V_{CE} = 25, V_{GE} = 0\text{ V} \quad f = 1\text{ MHz}$		12,3		nF
C_{oes}			0,76		nF
C_{res}			0,36		nF
Q_G	$V_{GE} = -8\text{V}...+15\text{V}$		2254		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		1		Ω
$t_{d(on)}$	$R_{Gon} = 1\ \Omega$ $di/dt = 1700\text{ A}/\mu\text{s}$	$V_{CC} = 300\text{V}$ $I_C = 200\text{A}$	93		ns
t_r			113		ns
E_{on}	$R_{Goff} = 1\ \Omega$ $di/dt = 2000\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$ $V_{GE} = -8\text{V}/+15\text{V}$	2,24		mJ
$t_{d(off)}$			317		ns
t_f			102		ns
E_{off}			7,89		mJ
$R_{th(j-c)}$	per IGBT		0,21		K/W

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Characteristics				min.	typ.	max.	Units
Symbol	Conditions						
Inverse Diode							
$V_F = V_{EC}$	$I_{Fnom} = 20 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$		1,45	1,7		V
		$T_j = 150^\circ\text{C}_{chiplev.}$		1,45	1,7		V
V_{F0}		$T_j = 25^\circ\text{C}$		1	1,1		V
		$T_j = 150^\circ\text{C}$		0,9	1		V
r_F		$T_j = 25^\circ\text{C}$		22,5	30		mΩ
		$T_j = 150^\circ\text{C}$		27,5	35		mΩ
I_{RRM}	$I_F = 20 \text{ A}$	$T_j = 150^\circ\text{C}$					A
Q_{rr}							μC
E_{rr}	$V_{GE} = -8 \text{ V}; V_{CC} = 300 \text{ V}$						mJ
$R_{th(j-c)D}$	per diode			3			K/W
Free-wheeling diode							
$V_F = V_{EC}$	$I_{Fnom} = 200 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$		1,4	1,6		V
		$T_j = 150^\circ\text{C}_{chiplev.}$		1,3	1,45		V
V_{F0}		$T_j = 25^\circ\text{C}$		0,95	1		V
		$T_j = 150^\circ\text{C}$		0,85	0,9		V
r_F		$T_j = 25^\circ\text{C}$		2,2	3		V
		$T_j = 150^\circ\text{C}$		2,1	2,7		V
I_{RRM}	$I_F = 200 \text{ A}$	$T_j = 150^\circ\text{C}$		175,8			A
Q_{rr}	$di/dt = 2000 \text{ A}/\mu\text{s}$			12			μC
E_{rr}	$V_{GE} = -15/+15 \text{ V}; V_{CC} = 300 \text{ V}$			4			mJ
$R_{th(j-c)FD}$	per diode			0,39			K/W
$R_{th(c-s)}$	per module				0,038		K/W
M_s	to heat sink M6			3	5		Nm
M_t	to terminals M6			2,5	5		Nm
w					310		g
Temperature sensor							
R_{100}	$T_s = 100^\circ\text{C} (R_{25} = 5\text{k}\Omega)$			493±5%			Ω
							K

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.

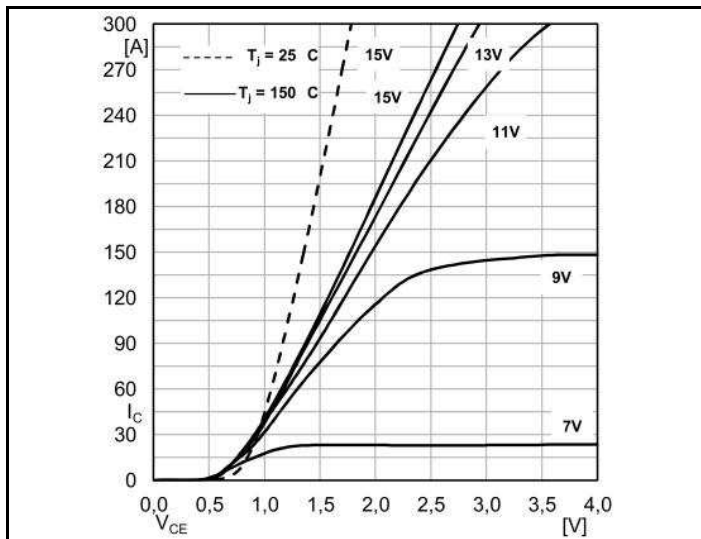


Fig. 1 Typ. output characteristic, inclusive $R_{CC+EE'}$

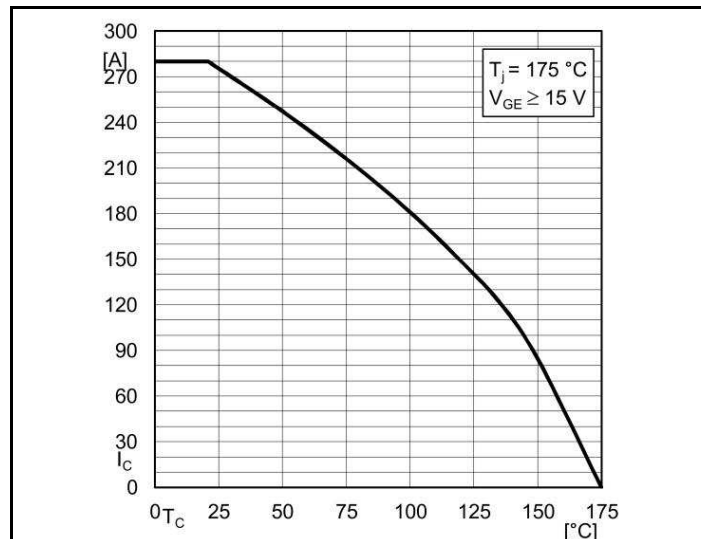


Fig. 2 Rated current vs. temperature $I_C = f(T_C)$

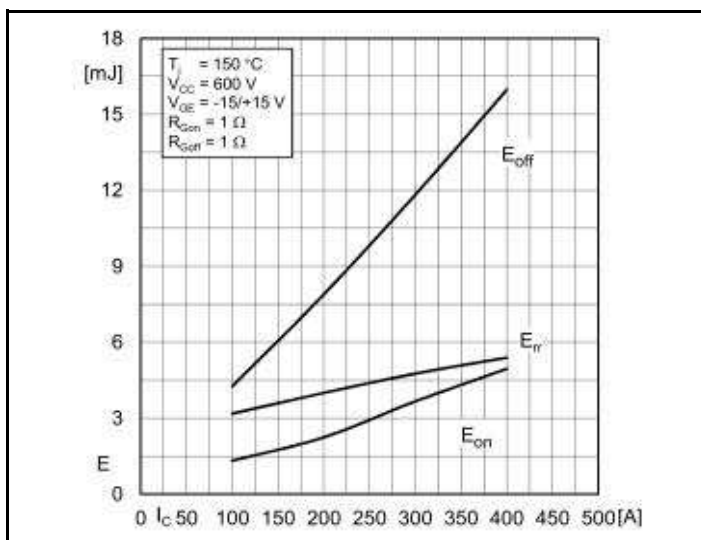


Fig. 3 Typ. turn-on /-off energy = $f(I_C)$

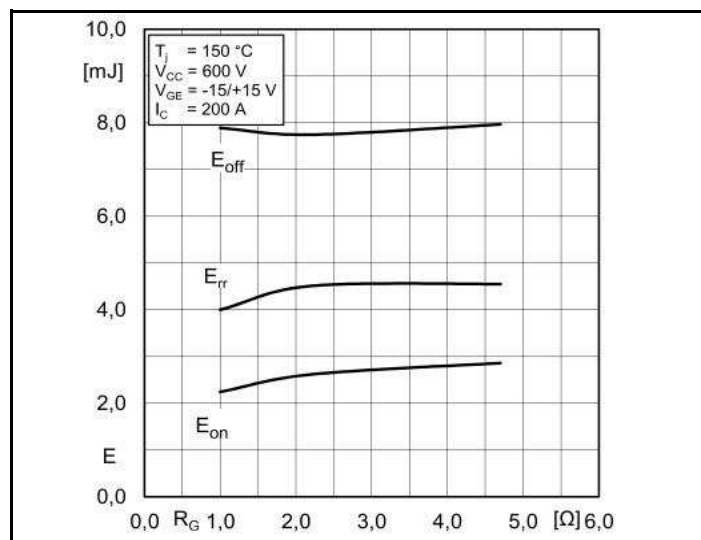


Fig. 4 Typ. turn-on /-off energy = $f(R_G)$

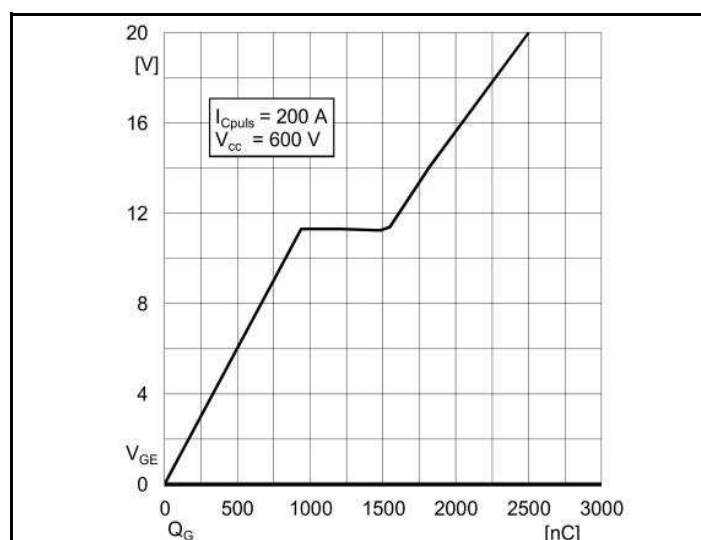
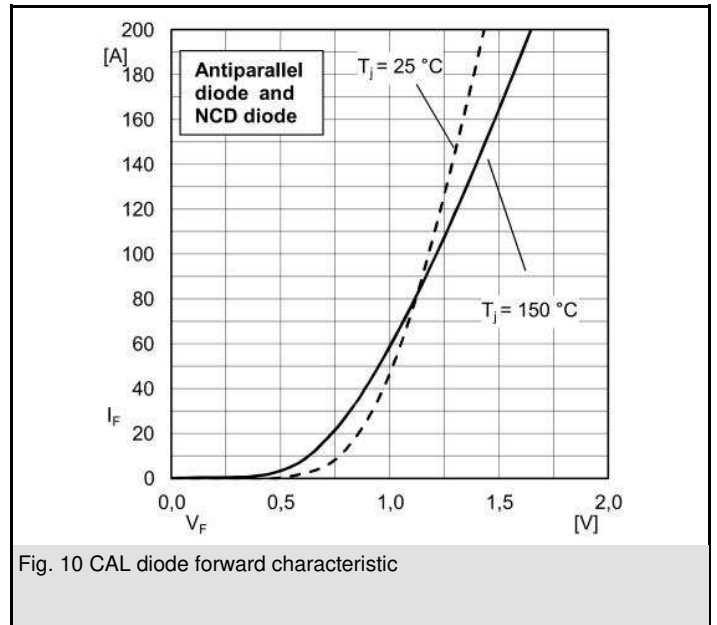
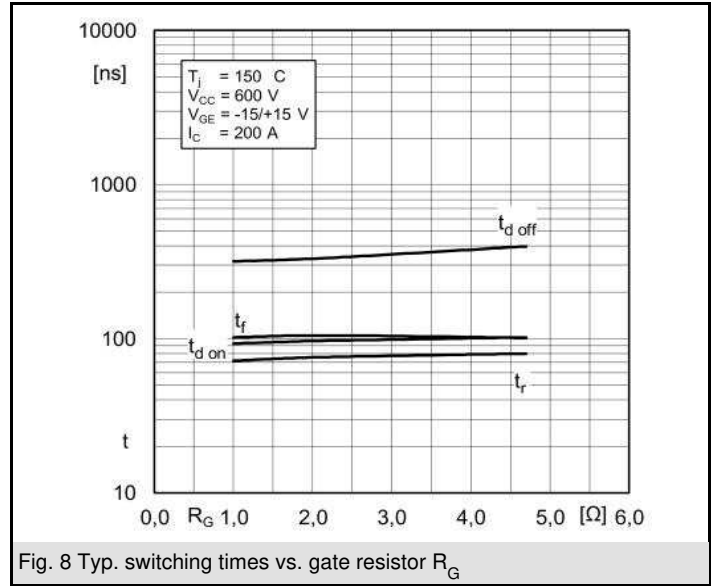
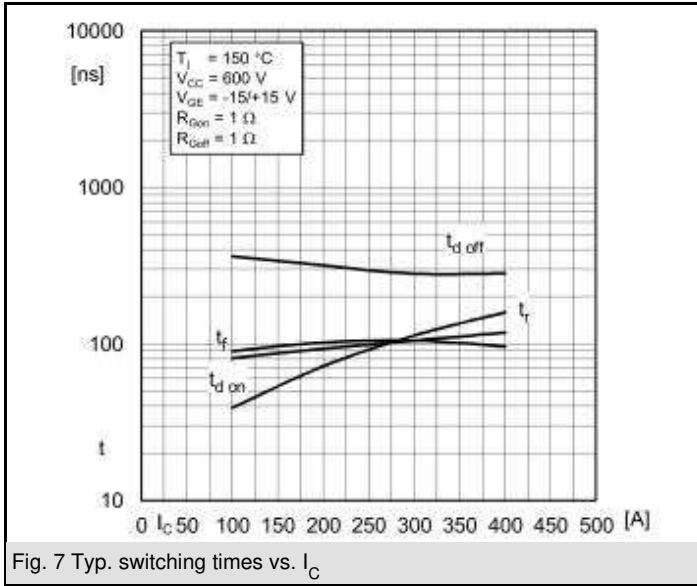


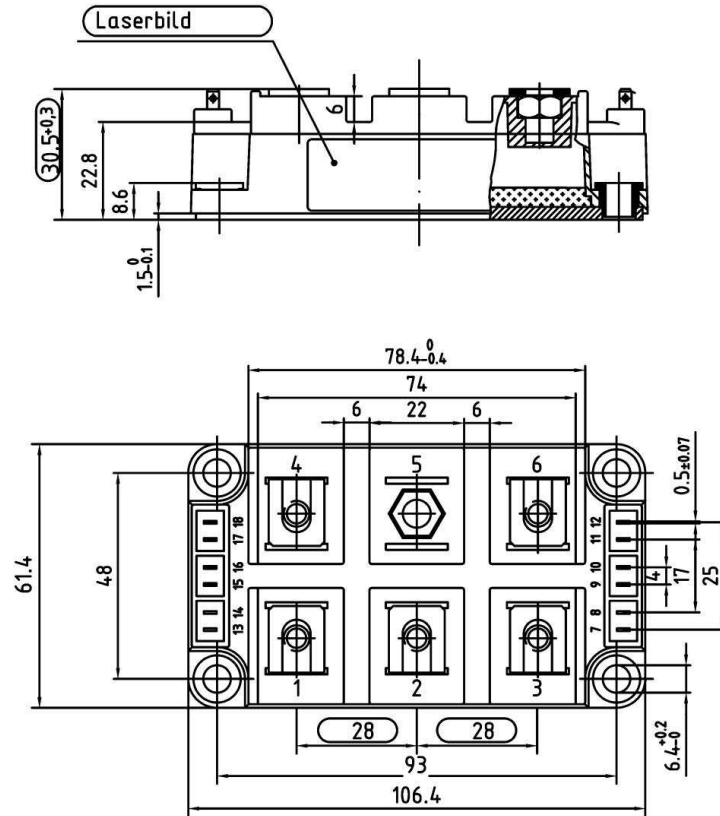
Fig. 6 Typ. gate charge characteristic



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UL recognized

file no. E 63 532



Case D61

